

<b>Notice of References Cited</b>	Application/Control No. 10/596,082		Applicant(s)/Patent Under Reexamination ALLARD ET AL.	
	Examiner SUSAN W. BERMAN		Art Unit 1765	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,790,802	09-2010	Allard et al.	524/590
*	B	US-7,767,731	08-2010	Chen et al.	523/118
*	C	US-7,384,989	06-2008	Allard et al.	522/171
*	D	US-7,963,769	06-2011	Qian, Xuejun	433/228.1
*	E	US-7,946,850	05-2011	Qian, Xuejun	433/228.1
*	F	US-6,998,425	02-2006	Chisholm et al.	522/182
*	G	US-3,754,972	08-1973	de Majistre et al.	427/507
*	H	US-4,687,709	08-1987	Brinkmeyer et al.	428/425.9
*	I	US-5,069,929	12-1991	Arai et al.	427/519
*	J	US-6,306,904	10-2001	Gordziel, Steven A.	514/530
*	K	US-6,440,519	08-2002	Takase et al.	428/65.2
*	L	US-2008/0251771	10-2008	Maxime et al.	252/519.33
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.